


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540270	<b>Applicant(s)/Patent Under Reexamination</b>  NAKANISHI ET AL.
	<b>Examiner</b>  Burney, Rachel L	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
430	109.4, 124.1	11/29/2007	/RLB/
528	272	11/29/2007	/RLB/
430	109.2	07/10/2008	/RLB/
528	283, 296, 302, 307, 308.6, 366	07/10/2008	/RLB/
430	123.4	04/10/2009	/RLB/

SEARCH NOTES		
Search Notes	Date	Examiner
Inventorship Search	11/29/2007	/RLB/
Text search in EAST (see search history print out)	11/29/2007	/RLB/
Consulted with SPE Mark Huff	12/03/2007	/RLB/
Consulted with Vasu Jagannathan	07/10/2008	/RLB/
Updated text search in EAST (see search history)	07/10/2008	/RLB/
Updated text search in EAST (see search history)	04/10/2009	/RLB/
Consulted with Chris Rodee	04/10/2009	/RLB/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
430	109.4, 124.1, 123.4	04/10/2009	/RLB/
528	272	04/10/2009	/RLB/

/R. L. B./  
Examiner.Art Unit 1795